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<b>Notice of References Cited</b>			Application/Control No. 10/587,531	Applicant(s)/Patent Under Reexamination HEYDER, MARTIN	
Examiner NAISHADH N. DESAI			Art Unit 2834	Page 1 of 2	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-362,572 A	05-1887	Name not available Clauss	30/269
*	B	US-1,323,188 A	11-1919	Name not available Humphris	411/164
*	C	US-3,002,794 A	10-1961	GROOT BLUEMINK GARY	384/204
*	D	US-5,237,228 A	08-1993	Fries, Hjalmar	310/87
*	E	US-5,811,903 A	09-1998	Ueno et al.	310/90
*	F	US-5,811,902 A	09-1998	Sato, Takashi	310/90
*	G	US-5,907,199 A	05-1999	Miller, Robin Mihekun	310/12
*	H	US-5,959,381 A	09-1999	Fischer et al.	310/90
*	I	US-6,024,177 A	02-2000	Winebrenner, Thomas E.	169/51
*	J	US-6,056,519 A	05-2000	Morita et al.	417/415
*	K	US-6,368,039 B2	04-2002	Wolfe et al.	411/526
*	L	US-2005/0012417 A1	01-2005	Fasterding et al.	310/090
*	M	US-2005/0184601 A1	08-2005	Kweon et al.	310/036

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 01268437 A	10-1989	Japan	AKATSUKA, JUN	H02K 05/173
	O	JP 05030701 A	02-1993	Japan	HIRAKAWA, TETSUO	H02K 05/173
	P	JP 2000308305 A	11-2000	Japan	TSUKAMOTO et al.	H02K 05/24
	Q	JP 2002336785 A	11-2002	Japan	IMAZU et al.	B06B 01/04
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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